Maximal charge injection of a uniform separated electron pulse train in a drift space

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A charge sheet model is proposed to study the space charge effect and uniformity of charge separation of an electron pulse train in a drift space. An analytical formula is derived for the charge density limit as a function of gap spacing, injecting energy and pulse separation. To consider the relativistic effects, the theoretical results are verified by numerical solutions up to 80 MeV. This model can be applied to the design of Smith-Purcell radiation, multiple-pulse electron beam for time resolved electron microscopy, and to free electron laser.

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I. INTRODUCTION

Consecutive electron pulses or multipulse comb beams, which are generated by comb-like laser pulse illuminated photocathode [1] or direct laser electron accelerator (DLA) [2], have wide applications, such as terahertz radiation sources [3], free electron laser (FEL) [4], high harmonics generation (HHG) processes [5] and four-dimensional ultrafast electron microscopy (UEM) [6]. The pre-bunched charge sources have the potential to greatly enhance the efficiency or power of the devices, currently attracting the attention of many scientists.

Current density and pulse duration of the electron pulses play an important role to these applications. Take Ref. [3] as an example, a scheme was proposed to enhance Smith-Purcell (SP) radiation [7] in the terahertz wavelength range by generating a train of prebunched electron beams. In this scheme, sufficient charge number per pulse is required to have enhanced SP radiation [8]. However, the space charge effect at high charge density may destroy the temporal profile of the pulses. Hence, studying the influence of space charge effect of multiple electron pulses in drift space is important.

At high current regime, the space charge effect will limit the maximum injected current density which is the so-called the space charge limited current (SCLC) density. Considering a one-dimensional (1D) planar accelerating diode with gap distance $L$ and gap voltage $V_g$, the maximal steady state SCLC density is given by the classical Child-Langmuir (CL) law [9,10] given by

$$J_{CL} = \frac{4}{9} \varepsilon_0 \sqrt{\frac{2eV_g^3}{mL^2}},$$

(1)

where $e$ and $m$ are, respectively, the charge and mass of the electron, and $\varepsilon_0$ is the free space permittivity (note that this equation presumes an initial velocity of zero). After leaving the diode’s accelerating region, the electrons enter the drift space region with a velocity $\sqrt{2eV_g/m}$ [a finite initial velocity from the injecting surface is considered, which is different from Eq. (1)]. For a drift space of length $d$ and of zero electric field, the SCLC density in a drift space [11] is expressed as

$$J_{DSCL} = \frac{32}{9} \varepsilon_0 \sqrt{\frac{2eV_g^3}{m d^2}}.$$

(2)

In past years, the studies of SCLC in a diode and a drift space have been revised extensively to consider various effects such as finite emission area [12–16], short pulse length and relativistic (and quantum) effects [17–24], semianalytical scaling for cylindrical and spherical diodes [25,26].

In this paper, we extend our previous work [24] of calculating the maximum charge density for a uniform electron pulse train in a diode to a drift space. In Ref. [24], a 1D model to study the space charge limited charge injection of a train of multiple electron pulse into a diode were presented. The charge sheet model was used to obtain an analytical formula, which can quickly provide such upper limit of charge density injection once the values of gap spacing, gap voltage, and the initial time separation between the pulses are provided.

In contrast to an accelerating diode, the boundary conditions at upstream and downstream ends of a drift space are of the same potential, and the electrons injected

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from the upstream end with an initial velocity that is determined by the accelerating diode. Unlike a diode for which the SCLC is determined by the zero electric field at the injecting end (or the cathode), the criteria of SCLC for a drift space is the minimal electric field occurring at the midpoint. By constructing a 1D charge sheet model, an analytical or semianalytical formula was derived to estimate the upper limit of the charge density per pulse for any given pulse interval, gap spacing, and injecting velocity in a drift space. To verify the formula, the consecutive electron pulses in Ref. [3] are used as an example to determine the maximum charge density per pulse while the pulse interval almost remains constant. By including relativistic effect, the model developed in the study is still valid for devices with the electron beam energy up to 80 MeV [2].

II. ANALYTICAL MODEL

Consider a single charge sheet of charge density \( \sigma \) injected into a drift space with an initial velocity \( v_0 = \sqrt{2eV_g/m} \) (injected by an accelerating diode with gap voltage \( V_g \)), as shown in Fig. 1(a). By solving Poisson’s equation \( \phi'' = -\frac{\sigma}{\epsilon_0} \delta(x-x_1) \) with the grounded boundary conditions on both electrodes \( \left[ \phi(0) = \phi(d) = 0 \right] \), the electric field profiles are \( E_1 = \frac{\sigma}{\epsilon_0} \left( \frac{d}{2} \right) \) and \( E_2 = -\frac{\sigma}{\epsilon_0} \left( 1 - \frac{x}{d} \right) \), where \( E_1 \) and \( E_2 \) are the fields acting on the downstream electrode or anode \( (x=d) \) and on the upstream electrode or cathode \( (x=0) \), respectively. The corresponding potential profiles of both regions as shown in Fig. 1(a) are respectively \( V_1(x) = -E_1x + E_1d \) and \( V_2(x) = E_2x \) [11].

If the charge sheet with the maximum density is located at the center of the drift space \( (x=d/2) \), the potential field profile is symmetric with respect to the mid-point, and the potential minimum at the center of the drift space equals to \( V_g \) based on energy conservation, i.e., \( V_{1,2}\left( \frac{d}{2} \right) = -V_g = \frac{1}{2}E_1 \). Thus we have the maximum charge density \( \sigma_1 = -4e_0 \frac{V_g}{\sigma} \) and the SCLC density is given by \( J_1 = \frac{\sigma_1}{\tau_p} \) where \( \tau_p \) is the pulse duration [22]. A normalized time scale \( X_{DSCL} = \frac{t_p}{\tau_{DSCL}} \) is introduced to define the ratio between the pulse duration and the transit time \( T_{DSCL} \) of SCLC in a drift space. The transit time is expressed as \( T_{DSCL} = \frac{3d}{\sqrt{8eV_g/m}} \) in the classical regime [11], and \( T_{RDSC} = \frac{2a}{\epsilon} \left( \sqrt{\frac{r_0^2}{m}-1} \right)^{1/2} \) in the relativistic regime. Here, \( G(\gamma_0) = \int_{\gamma_0}^{\gamma_m} \left( \sqrt{r^2 - 1} - \sqrt{r_0^2 - 1} \right)^{1/2} dr \) and \( \gamma_m \) are the maximum and minimum Lorentz factors, respectively.

By solving \( \phi'' = -\frac{\sigma}{\epsilon_0} \sum_{n=1}^{N} \delta(x-x_n) \) for \( N \) number of pulses and assuming that pulses are distributed symmetrically with equal pulse spacing \( \Delta_x \), the potential minimum in the center of the drift space is

\[
V_g = \left\{ \begin{array}{ll}
\frac{d}{2} \frac{\sigma}{\epsilon_0} \sum_{n=1}^{N} \left( \frac{1}{2} - (n-1) \frac{\Delta_x}{d} \right) - \frac{1}{2}, & N \text{ odd} \\
\frac{d}{2} \frac{\sigma}{\epsilon_0} \sum_{n=1}^{N} \left( 1 - (2n-1) \frac{\Delta_x}{d} \right), & N \text{ even}
\end{array} \right.
\]

Letting \( \Delta_x = \nu_0 \Delta_x \), the maximum charge density is given by

\[
\frac{\sigma_N}{\sigma_1} = \left\{ \begin{array}{ll}
\left[ N - \frac{\nu_0 \Delta_x}{d} \left( \frac{N^2-1}{2} \right) \right]^{-1}, & N \text{ odd} \\
\left[ N - \frac{\nu_0 \Delta_x}{d} \left( \frac{N^2}{2} \right) \right]^{-1}, & N \text{ even}
\end{array} \right.
\]

(4)

For better illustrations, a simple diagram for two charge sheets is shown in Fig. 1(b). Note that the two expressions in Eq. (4) are identical at \( N \gg 1 \), and \( \sigma_N = \frac{\nu_0 \Delta_x}{d} T_0 \) recovers to the result of single charge sheet at \( \nu_0 \Delta_x \rightarrow 0 \). The maximum number of charge sheets in the drift space can be estimated by \( N_{\text{max}} \cong \left[ T_0 \frac{\epsilon_0}{d} \right] \), where \( T_0 \cong \frac{d}{\nu_0} \) is the transit time of single charge sheet.

To consider the dynamic behavior of the charge sheets, we solve the normalized equation of motion (EOM) numerically for the position \( x_n(t) \) of each sheet, which is injected into the drift space. The normalized charge density (in terms of \( \sigma_1 \)) is

\[
\bar{\sigma}(\bar{t}) = \frac{\sigma_N}{\sigma_1} \sum_{n=1}^{N} x_n(\bar{t}),
\]

(5)

FIG. 1. A drift space with gap spacing \( d \) with (a) single pulse injection and (b) two pulse injections, respectively.
where $\bar{x}_n = \frac{\sigma_n(t)}{\sigma}$ is the normalized position of $n$th sheet at normalized time $\tilde{t} = \frac{t}{T_{DSCL}}$, respectively. The normalized temporal electric field (in terms of $\frac{\sigma_n(t)}{\sigma_0}$) acting on each charge sheet is

$$E_n(\tilde{t}) = \frac{\sigma_n}{\sigma_1} \sum_{n=1}^{N} \bar{x}_n(\tilde{t}) - \frac{\sigma_N}{\sigma_1} \left( n - \frac{1}{2} \right). \quad (6)$$

The normalized EOM is given by

$$\begin{cases}
\frac{d\bar{x}_n}{d\tilde{t}} = 0.75 \bar{E}_n(\tilde{t}) \\
\frac{d\bar{v}_n}{d\tilde{t}} = 1.5 \bar{v}_n(\tilde{t})
\end{cases} \quad (7)$$

which are solved numerically with initial conditions: $\bar{x}_n(0) = 0; \quad \bar{v}_n(0) = 1$, where $\bar{v}_n = v_n/v_0$. Using $J(\tilde{t}) = \frac{d\bar{v}_n}{d\tilde{t}}$, we derive the normalized current density (in terms of $\frac{\sigma_1}{T_{DSCL}}$) as

$$J(\tilde{t}) = 1.5 \left( \frac{\sigma_N}{\sigma_1} \right) \sum_{n=1}^{N} \bar{v}_n(\tilde{t}). \quad (8)$$

### III. RESULTS

As an example, we consider a 50 keV prebunched electron beam with temporal pulse spacing $\Delta_t = 2.16$ ps passing above a 5 cm grating [3]. The corresponding transit time for single charge sheet is $T_0 \approx 377$ ps and the maximum number of charge sheet is $N_{\text{max}} \approx \left[ \frac{T_0}{\Delta_t} \right] = 175$.

In Figs 2(a) and 2(d), we show the trajectories of each charge sheet and its corresponding current density $(J)$ by solving Eqs. (7) and (8) for a given charge density $\sigma = \sigma_{175}$ from Eq. (4), respectively. It is found that some of the injected charge sheets are reflected due to the space charge effect and the negative current density is observed as shown in Fig. 2(d). This finding implies that Eq. (4) has overestimated the maximal charge density. Hence, a lower charge density is expected to reduce the space charge effect in order to maintain a temporally uniform pulse structure. In doing so, we introduce $f (<1)$ as a fraction of the maximum charge density $\sigma_N$ (from Eq. (4)), which gives $\sigma = f \sigma_N$. Figure 2(b) and 2(e) show the trajectories of each charge sheet and the current density with a given charge density $\sigma = 0.7\sigma_{175}$ for $f = 0.7$. By defining $\Delta_f$ to be the final temporal separation of the last two charge sheets arriving at the anode, we can use $\Delta_f$ to measure the uniformity of pulse intervals. From Fig. 2(b), there is expansion of charge sheet separation as shown in Fig. 2(g) [magnification of Fig. 2(b) near $x = 1$ region, and $\Delta_f = 6.35$ ps]. This suggests that the charge density is still too large even if there are no reflections of charge sheets. By reducing to $f = 0.1$, Figs. 2(c) and 2(f) show the trajectories of all charge sheets and the current density at $\sigma = 0.1\sigma_{175}$. In these two figures, a temporally uniform charge sheet train is demonstrated in Fig. 2(h) [magnification of Fig. 2(c) near $x = 1$ region, and $\Delta_f = 2.26$ ps], and the current density maintains a constant until the last charge sheet passing though the gap.

The open circles in Fig. 3 show the final time intervals $\Delta_f$, as a function of $f$ for $N = 19$ (red), 175 (black) and 320 (blue), which indicates that $\Delta_f$ converges to $\Delta_t$ as $f \to 0.1$. For larger $N$, the deviation of $\Delta_f$ from $\Delta_t$ occurs at smaller $f$ as expected. From the experiment reported in Ref. [3], the number of pulse used was reported to be $N = 19$ and $N = 320$. From our results, the differences between $\Delta_f$ and $\Delta_t$ are within 10% at $f \to 0.1$ and is further reduced to 2% at $f \to 0.01$. Thus our model can be used to correctly estimate the maximal charge density based on the acceptable nonuniformity of the pulse train in various applications, including terahertz radiation sources [3], free electron laser (FEL) [4], high harmonics generation (HHG) processes [5], and four-dimensional ultrafast electron microscopy (UEM) [6], etc. Dependent on specific application, if the proposed 10% deviation is not good enough, the model
where \( \Delta_r \) is used in our calculation. The density \( \rho \) generated by DLA, thus we can consider the given charge setting, there are about 10 microbunches in a train generated by DLA, thus we can consider the given charge density is
\[
\sigma_N = \frac{e N N_{\text{max}}}{N \sqrt{2 \pi}} \left( 1 - \frac{1}{2} \left( \frac{e V_g}{m \sigma_0} \right) \left( \frac{N_{\text{max}}}{f^2} \right) \right)^{1/2}.
\]
The solid circles (for the diode model) in Fig. 3 show the final time intervals \( \Delta_f \) as a function of \( f \) for \( N = 19 \) (red), 175 (black) and 320 (blue), which shows that \( \Delta_f \) also converges to \( \Delta_r \) at \( f \rightarrow 0.1 \). The comparison implies that drift space cases can be revised to calculate smaller value of \( f \) in order to have smaller deviation.

To compare with the diode model [24], the same gap spacing \( d = 5 \text{ cm} \), gap voltage \( V_g = 50 \text{ kV} \), and the temporal pulse spacing \( \Delta_r = 2.16 \text{ ps} \) are used in the calculation. According to our previous work, the maximum number of charge sheets in a diode is \( N_{\text{max}} = 350 \) and the corresponding maximum charge density is
\[
\sigma_N = \frac{e N N_{\text{max}}}{N \sqrt{2 \pi}} \left( 1 - \frac{1}{2} \left( \frac{e V_g}{m \sigma_0} \right) \left( \frac{N_{\text{max}}}{f^2} \right) \right)^{1/2}.
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electrons are heavier, and more difficult to be accelerated (or decelerated) when propagating in the drift space. Thus, the high energy train of charge sheet is much easier to maintain the temporal profile and Eq. (4) is able to provide a good estimation because the deviation is less than 4% (at \( f = 1 \)). To illustrate that at very high energy, the deviation is less than 1% around \( \Delta t / \Delta \tau = 1 \), a case of 500 MeV with same \( \Delta T = 3 \) fs and \( N = 36 \) (but at higher \( d = 31 \) mm) is plotted (solid black circles) in Fig. 4. In the future, it will be interesting to do a full relativistic particle-in-cell (PIC) simulation to compare with this finding.

To further verify the theory, the practical case reported in Ref. [3] is taken as another test case. For a beam radius (per bunch) of \( r_b = 42 \) [\( \mu \)m], we have charge per bunch \( Q = 1 \) [\( \mu \)C], initial kinetic energy \( K_e = 50 \) [keV], number of bunches \( N = 19 \), temporal pulse spacing \( \Delta_t = 2.16 \) [ps] and the gap spacing \( d = 5 \) [cm]. The corresponding charge density is about \( \sigma = \frac{Q}{\pi d^2} \approx 0.45 \sigma_{175} \). This corresponds to \( f = 0.45 \) which gives 14% discrepancy between \( \Delta t \) and \( \Delta \tau \) based on our calculation.

The 14% discrepancy seems to be acceptable in Ref. [3] since the purpose of the pulse train is to enhance the power of SP radiation, but not to the time-resolved electron microscopy [6], in which the diagnostics is more sensitive to the time structure of the pulse train. Moreover, the main interaction region between the pulse train and the grating for generating SP radiation is near the center of the drift space, thus the temporal separation is relatively well-maintained as compared to the anode region with higher degradation as shown in Fig. 2(b).

Finally, our theory is a 1D sheet model, therefore the traverse effect is ignored. The traverse effect would decrease the charge density while charges are moving and may help maintain better temporal separations. This fact is supported by Refs. [27,28]. We would also like to comment on the validity of the charge sheet model. The electron pulse lengths are \( \tau_p \leq \tau_{\text{DSC}} \approx 20 \) [fs] in Ref. [3] and \( \tau_p \approx 1 \) [fs] in Ref. [2]. Both of the corresponding normalized pulse lengths are \( X_{\text{DSC}} \lesssim \frac{\tau_p}{\tau_{\text{DSC}}} \approx 10^{-5} \ll 1 \), which is consistent with the assumption of our model. Prior works by Valfells et al. [17], Zhang et al. [22], and most recently by Liu et al. [24] had also clearly indicated that analytical results based on charge sheet model agree very well with the particle-in-cell or many-body simulation as long as \( X_{\text{DSC}} < 0.1 \). The N-sheets model also appears in Ref. [29] as a Monte Carlo simulation which has a distinct parallel interest with our works. It is worthwhile to mention it as the end of this paper.

**IV. SUMMARY**

In summary, a theoretical model in the paper is constructed to study the space charge effects of \( N \) number of charge sheets injected into a drift space with an initial kinetic energy injection up to 80 MeV (including relativistic effect). A formula [Eq. (4)] is derived to determine the upper limit of the charge density per pulse to maintain the uniform time structure of the pulse train. The model may be useful in the design of Smith-Purcell radiation, multiple-pulse electron beam for time resolved electron microscopy, free electron laser or any applications with charge pulse trains over a wide range of parameters.

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